

<u>AP50N06BD/Y</u>

60V N-Channel Enhancement Mode MOSFET

Description

The AP50N06BD/Y uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 60V I_D =50A

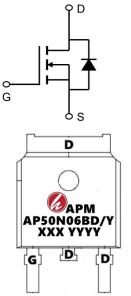
 $R_{DS(ON)} < 20m\Omega @ V_{GS}=10V (Type: 16m\Omega)$

Application

Battery protection

Load switch

Uninterruptible power supply





Package Marking and Ordering InformationProduct IDPackMarkingQty(PCS)AP50N06BDTO-252-3LAP50N06BD XXX YYYY2500AP50N06BYTO-251-3LAP50N06BY XXX YYYY4000

Absolute Maximum Ratings@T_i=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units	
VDS	Drain-Source Voltage	60	V	
VGS	Gate-Source Voltage	±20	V	
I₀@Tc=25℃	Continuous Drain Current, V _{GS} @ 10V ¹	50	А	
ID@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	22	A	
IDM	Pulsed Drain Current ² 150		А	
EAS	Single Pulse Avalanche Energy ³	39.2	mJ	
IAS	Avalanche Current	35	А	
P₀@Tc=25℃	Total Power Dissipation ⁴	45	W	
TSTG	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
R₀JA	Thermal Resistance Junction-Ambient ¹	62	°C/W	
R ₀ JC Thermal Resistance Junction-Case ¹		2.8	°C/W	

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Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60	65		V	
∆BVDSS/∆TJ	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.057		V/°C	
RDS(ON)		V _{GS} =10V , I _D =20A		16	20	mΩ	
	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =10A		20	25		
VGS(th)	Gate Threshold Voltage		1.2	1.6	2.5	V	
$\bigtriangleup V_{\text{GS(th)}}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250$ uA		-5.68		mV/°C	
IDSS	Drain-Source Leakage Current	$V_{\text{DS}}\text{=}48\text{V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^{\circ}\text{C}$			1	uA	
1000		V_{DS} =48V , V_{GS} =0V , T_{J} =55°C			5		
IGSS	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA	
gfs	Forward Transconductance	V_{DS} =5V , I_{D} =15A		45		S	
R _g	Gate Resistance	$V_{\text{DS}}\text{=}0V$, $V_{\text{GS}}\text{=}0V$, f=1MHz		1.7		Ω	
Qg	Total Gate Charge (4.5V)			28		nC	
Q_gs	Gate-Source Charge	V _{DS} =48V , V _{GS} =4.5V , I _D =15A		3.5			
Q_{gd}	Gate-Drain Charge			6.4			
Td(on)	Turn-On Delay Time			7.2		- ns	
Tr	Rise Time	V _{DD} =30V , V _{GS} =10V , R _G =3.3□,		38			
Td(off)	Turn-Off Delay Time	I _D =15A		34			
T _f	Fall Time			8.2			
Ciss	Input Capacitance			1680		pF	
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		115			
Crss	Reverse Transfer Capacitance			85			
Is	Continuous Source Current ^{1,5}				30	Α	
ISM	Pulsed Source Current ^{2,5}	$V_{G}=V_{D}=0V$, Force Current			152	Α	
VSD	Diode Forward Voltage ²	V _{GS} =0V , I _S =A , T _J =25℃			1	V	
t _{rr}	Reverse Recovery Time			19.6		nS	
Q _{rr}	Reverse Recovery Charge	IF=15A , dI/dt=100A/µs , Tյ=25℃		14.2		nC	

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

 $2 \ \ \$ The data tested by pulsed , pulse width . The EAS data shows Max. rating .

3、The test cond \leq 300us duty cycle \leq 2%, duty cycle ition is TJ =25 $^{\circ}$ C, VDD =35V, VG =10V, RG =25 Ω , L=0.1mH, IAS =30A

 $4\,{\scriptstyle \smallsetminus}\,$ The power dissipation is limited by $175\,{\rm ^{\circ}C}$ junction temperature

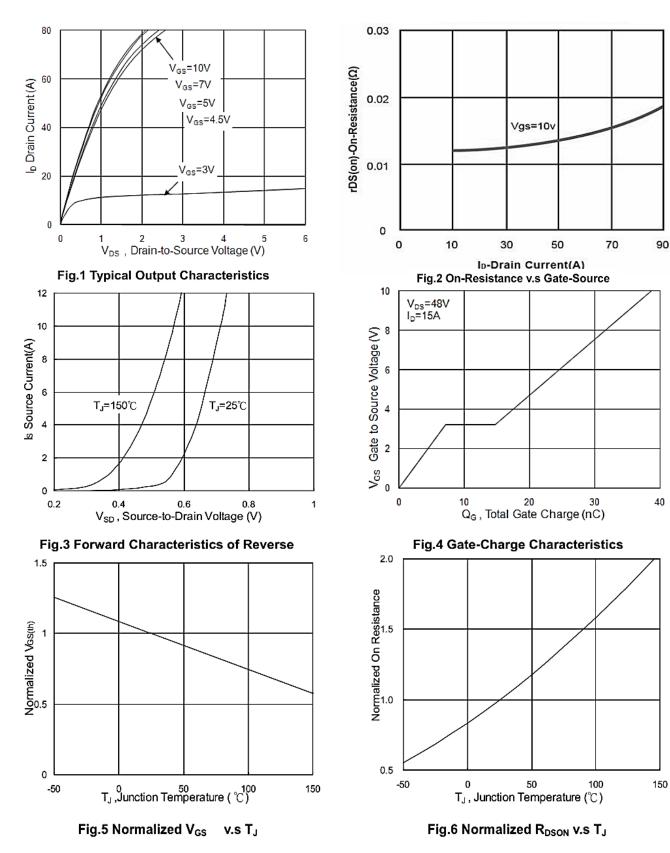
5. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

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Typical Characteristics



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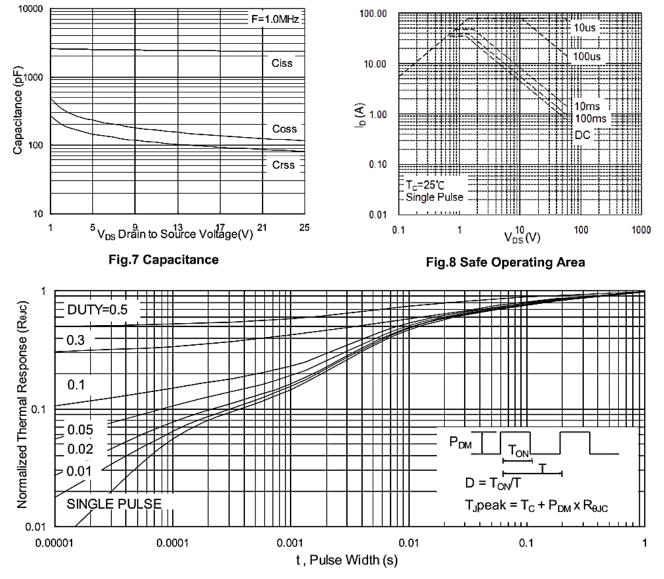


Fig.9 Normalized Maximum Transient Thermal Impedance

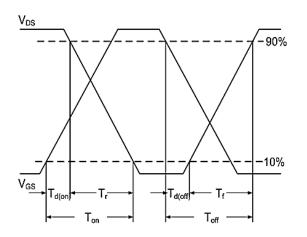


Fig.10 Switching Time Waveform

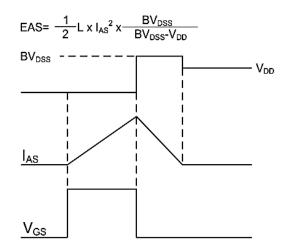
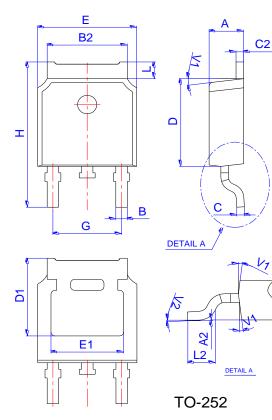


Fig.11 Unclamped Inductive Switching Waveform



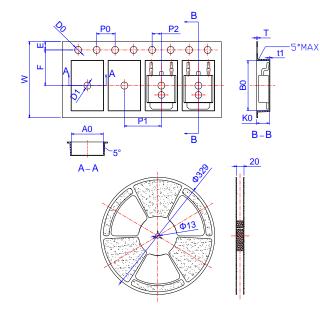
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Package Mechanical Data:TO-252-3L



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
A	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	

Reel Spectification-TO-252



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
W	15.90	16.00	16.10	0.626	0.630	0.634	
E	1.65	1.75	1.85	0.065	0.069	0.073	
F	7.40	7.50	7.60	0.291	0.295	0.299	
D0	1.40	1.50	1.60	0.055	0.059	0.063	
D1	1.40	1.50	1.60	0.055	0.059	0.063	
P0	3.90	4.00	4.10	0.154	0.157	0.161	
P1	7.90	8.00	8.10	0.311	0.315	0.319	
P2	1.90	2.00	2.10	0.075	0.079	0.083	
A0	6.85	6.90	7.00	0.270	0.271	0.276	
B0	10.45	10.50	10.60	0.411	0.413	0.417	
K0	2.68	2.78	2.88	0.105	0.109	0.113	
Т	0.24		0.27	0.009		0.011	
t1	0.10			0.004			
10P0	39.80	40.00	40.20	1.567	1.575	1.583	

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